1 188787 11821 83118 81111 8 8181 81211 81881 18181 1781 1881	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/605,481	CHEN ET AL.	
Examiner	Art Unit	
Fugene Lee	2815	

SEARCHED						
Subclass	Date	Examiner				
347,348	2/15/2005	EL				
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	Subclass	Subclass Date				

INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
searched EAST, USPAT, JPO, EPO	2/15/2005	EL	
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